

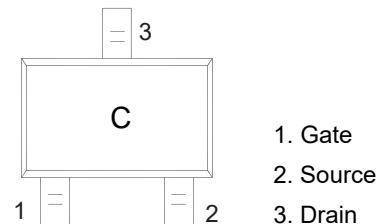
SOT-523 Plastic-Encapsulate MOSFETS

Features

- ◆ Low On-Resistance
- ◆ Low Gate Threshold Voltage
- ◆ Low Input Capacitance
- ◆ Fast Switching Speed
- ◆ Low Input/Output Leakage
- ◆ Lead Free By Design/RoHS Compliant (Note 2)
- ◆ ESD Protected up to 2kV

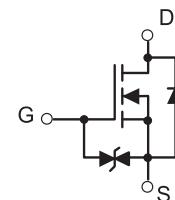
SOT-523

ROHS
COMPLIANT



1. Gate
2. Source
3. Drain

Equivalent Circuit



Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	20	V
Gate-Source Voltage			V_{GSS}	± 6	V
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^\circ\text{C}$	I_D	0.63	A
		$T_A = 85^\circ\text{C}$		0.45	
Pulsed Drain Current			I_{DM}	6	A

Thermal Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 1)	P_D	0.28	W
Thermal Resistance, Junction to Ambient	R_{JJA}	452	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Notes:

1. Device mounted on FR-4 PCB.
2. No purposefully added lead.

Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 4)						
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current $T_J = 25^\circ\text{C}$	I_{DSS}	-	-	100	nA	$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	-	-	± 1.0	μA	$V_{\text{GS}} = \pm 4.5\text{V}, V_{\text{DS}} = 0\text{V}$
ON CHARACTERISTICS (Note 4)						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	0.5	-	1.0	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{\text{DS (ON)}}$	-	0.3	0.4	Ω	$V_{\text{GS}} = 4.5\text{V}, I_D = 600\text{mA}$
			0.4	0.5		$V_{\text{GS}} = 2.5\text{V}, I_D = 500\text{mA}$
			0.5	0.7		$V_{\text{GS}} = 1.8\text{V}, I_D = 350\text{mA}$
			-	1.4		S
Forward Transfer Admittance	$ Y_{fs} $	-	1.4	-	S	$V_{\text{DS}} = 10\text{V}, I_D = 400\text{mA}$
Diode Forward Voltage (Note 4)	V_{SD}	-	0.7	1.2	V	$V_{\text{GS}} = 0\text{V}, I_S = 150\text{mA}$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{iss}	-	60.67	-	pF	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	-	9.68	-	pF	
Reverse Transfer Capacitance	C_{rss}	-	5.37	-	pF	
Total Gate Charge	Q_g	-	736.6	-	pC	
Gate-Source Charge	Q_{gs}	-	93.6	-	pC	$V_{\text{GS}} = 4.5\text{V}, V_{\text{DS}} = 10\text{V}, I_D = 250\text{mA}$
Gate-Drain Charge	Q_{gd}	-	116.6	-	pC	
Turn-On Delay Time	$t_{\text{D(on)}}$	-	5.1	-	ns	
Turn-On Rise Time	t_r	-	7.4	-	ns	$V_{\text{DD}} = 10\text{V}, V_{\text{GS}} = 4.5\text{V}, R_L = 47\Omega, R_G = 10\Omega, I_D = 200\text{mA}$
Turn-Off Delay Time	$t_{\text{D(off)}}$	-	26.7	-	ns	
Turn-Off Fall Time	t_f	-	12.3	-	ns	

Notes: 4. Short duration pulse test used to minimize self-heating effect.

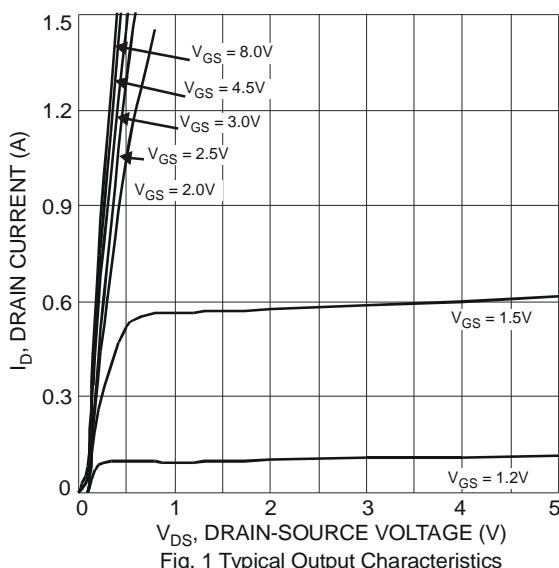


Fig. 1 Typical Output Characteristics

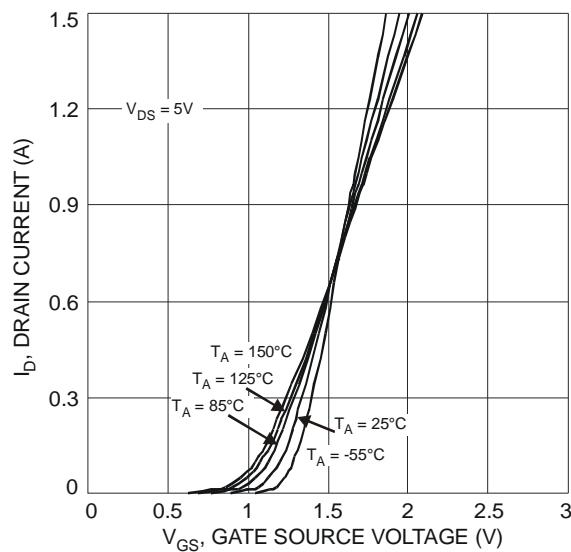


Fig. 2 Typical Transfer Characteristics

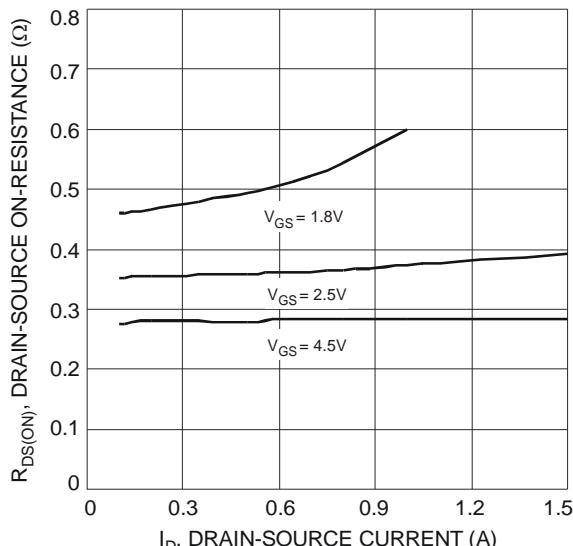


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

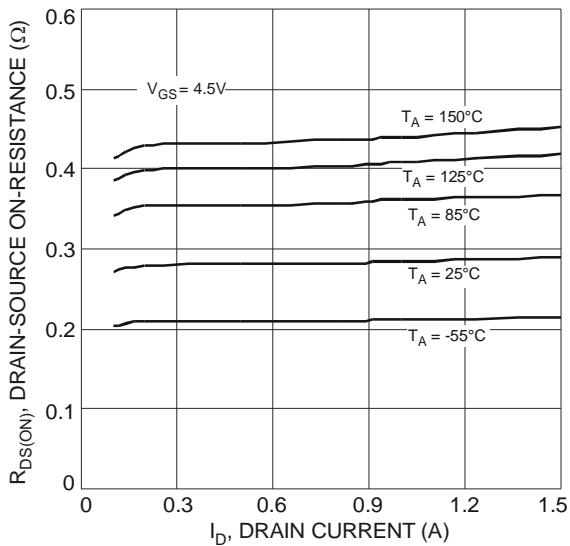


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

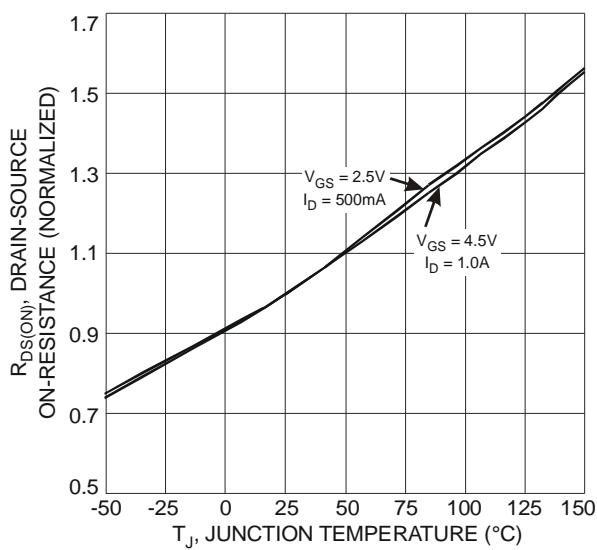


Fig. 5 On-Resistance Variation with Temperature

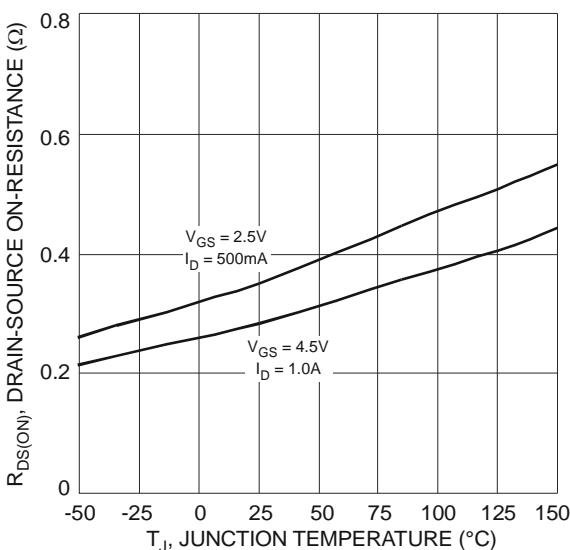


Fig. 6 On-Resistance Variation with Temperature

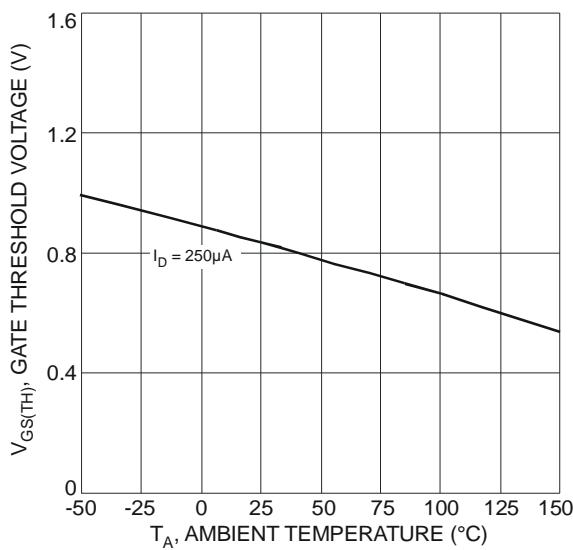


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

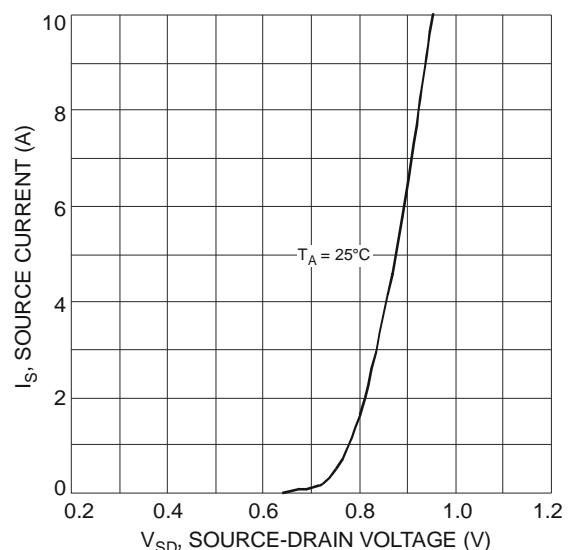


Fig. 8 Diode Forward Voltage vs. Current

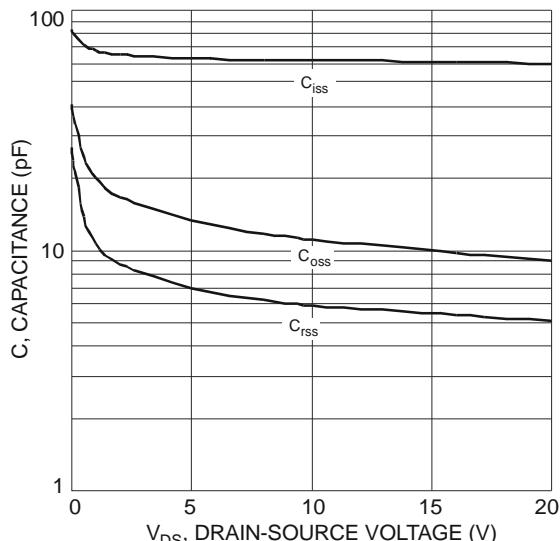


Fig. 9 Typical Capacitance

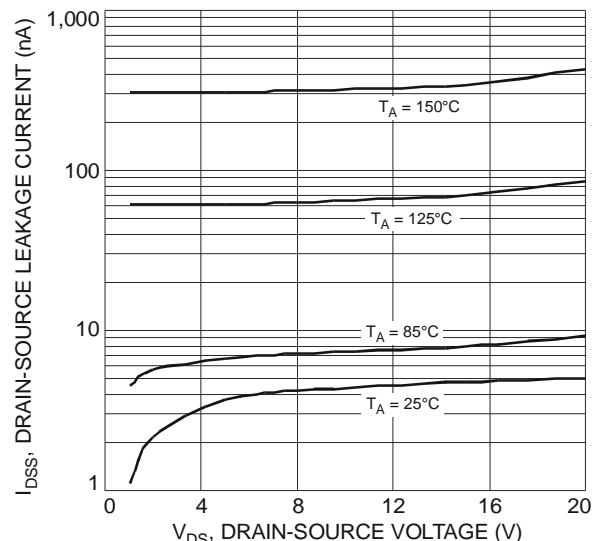


Fig. 10 Typical Drain-Source Leakage Current
vs. Drain-Source Voltage

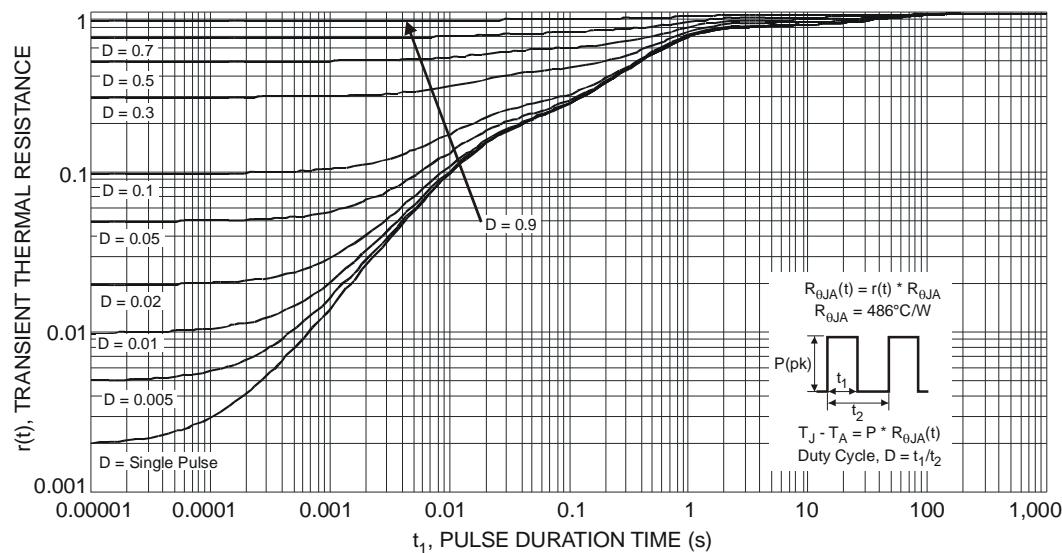
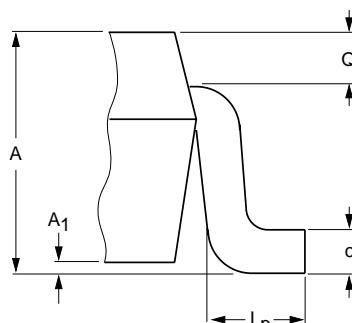
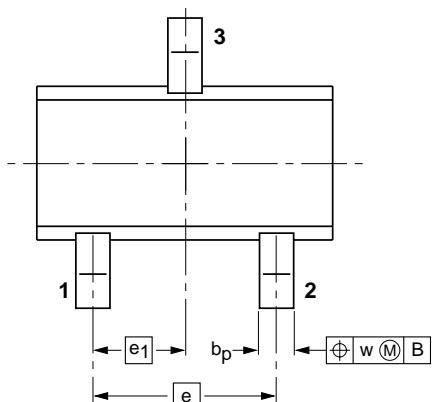
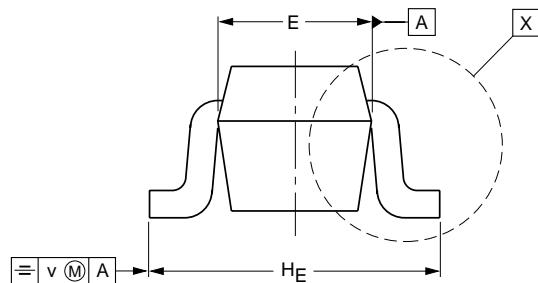
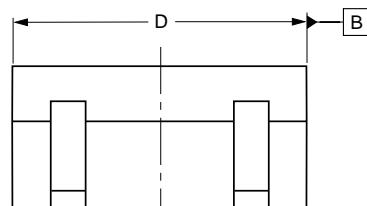


Fig. 11 Transient Thermal Response

SOT-523



0 0.5 1 mm
scale

DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max	b_p	c	D	E	e	e_1	H_E	L_p	Q	v	w
mm	0.95 0.60	0.1	0.30 0.15	0.25 0.10	1.8 1.4	0.9 0.7	1	0.5	1.75 1.45	0.45 0.15	0.23 0.13	0.2	0.2